

Supporting information-Probing and Quantifying Cathode Charge Heterogeneity in Li Ion Batteries

Yuxin Zhang,[†] Zhijie Yang,[†] Chixia Tian^{*b}

^a Department of Chemistry, Virginia Tech, Blacksburg, VA 24061, USA

^b Academy of Integrated Science, Virginia Tech, Blacksburg, VA 24061, USA

† Equal contribution, *Email: ctian@vt.edu

Table S1. Summary of key charge heterogeneity characterization techniques covered in this review.

Technique	Properties investigated	Sample environment	Pros and Cons
Confocal diffraction X-ray	Bulk crystal structures, phase stability	Electrode samples	Can be used to map phases at different depths of an electrode. Good for thick electrodes. Spatial resolution is less appealing.
Transmission Microscopy (TXM) X-ray	2-D, 3-D imaging, morphological, elemental distribution and chemical state information	Electrode particles, or small regions in electrodes.	Real-space full-field imaging technique. Spatial resolution is ~30 nm. Element-specific. Data collection is slow and challenging for in situ experiments.
Scanning transmission X-ray Microscopy (STXM),	2-D, 3-D imaging and mapping of element distributions and chemical states.	Electrode particles	Scanning imaging technique. Uses X-ray absorption spectroscopy to map elemental distributions and oxidations states. Data collection is slow and difficult for in situ experiments.
X-ray tomography	3-D imaging, elemental distribution, morphological information, oxidation states	Electrode particles, electrodes, cells	Full-field imaging technique. Need to have reconstruction technique to build 3D images. Can be coupled with XAS to give composition and oxidation state information in 3D.
Scanning transmission electron microscope (STEM)-electron energy-loss spectroscopy (EELS)	2-D, 3-D imaging, elemental mapping, oxidation states,	Nanoparticles	Scanning imaging mode, with good spatial resolution, elemental and oxidation state mapping, potentially 3D with reconstruction
Raman imaging	2-D imaging	Electrode samples	Spatial resolution is limited. easily accessible in most institutions.